

<b>Notice of References Cited</b>	Application/Control No. 10/528,848	Applicant(s)/Patent Under Reexamination HOSHINO ET AL.	
	Examiner Scott D. Long	Art Unit 1633	Page 1 of 1

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*	B	US-5,840,528	11-1998	Van Ooyen, Albert Johannes Joseph	435/69.1
*	C	US-5,744,341	04-1998	Cunningham et al.	435/189
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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